

Application/Control	No.
10/750,872	

Applicant(s)/Patent under Reexamination
LEE ET AL.

Art Unit

Examiner
Chen-Wen Jiang

3744

		ORIGINAL				INTERNATIONAL CLASSIFICATION									
CLASS SUBCLASS							CI	AIMED		NON-CLAIMED					
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-(Assi	stant Exam	iner) (C	Qate)	CHE	YW5	N JIA	NG	14%	Total Claims Allowed: 17						
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12	8			38			68]		98			128			158			188
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